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P/1250-293

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of

New York, New York

Takushi YOSHIDA, et. al.

Date:

November 14, 2005

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Group Art Unit:

Filed:

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APPARATUS, PROGRAM AND RECORDING MEDIUM

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

SUBMISSION

Sir:

Submitted herewith is a copy of art together with a form listing the same for the convenience of the Examiner.

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents P.O. Box 1450, Alexandria, VA 22313-1450, on November 14, 2005

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November 14, 2005

Date of Signature

Respectfully submitted,

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	2004-025057	01-2004	Japan			Abstract		
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)								
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